

Notice of References Cited	Application/Control No. 10/790,728		Applicant(s)/Patent Under Reexamination HAN, CHEUL KYUNG	
	Examiner LINH T. NGUYEN		Art Unit 2627	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0043711	03-2003	Mashimo et al.	369/47.39
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NON-PATENT DOCUMENTS

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